

Docket No.: 67161-105

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of	:	Customer Number: 20277
	:	
Kengo ARITOMI, et al.	:	Confirmation Number:
	:	
Serial No.:	:	Group Art Unit:
	:	
Filed: September 30, 2003	:	Examiner:
	:	
For: SEMICONDUCTOR MEMORY DEVICE HAVING REDUCED CURRENT DISSIPATION IN DATA HOLDING MODE		

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

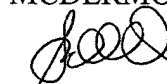
The relevance of each of the ten references listed on the attached Form 1449, are discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

A handwritten signature in black ink, appearing to read 'S. Becker', written over a horizontal line.

Stephen A. Becker
Registration No. 26,527

600 13th Street, N.W.
Washington, DC 20005-3096
(202) 756-8000 SAB:gv
Facsimile: (202) 756-8087
Date: September 30, 2003

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 67161-105		SERIAL NO.	
APPLICANT Kengo ARITOMI, et al.							
FILING DATE September 30, 2003				GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US					
		US					
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ¹ -Number ² -Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
		P2002-133862A	05/10/2002	NEC CORP.		JAPAN (w/English Abstract)	
		P2001-250378A	09/14/2001	HITACHI LTD.		JAPAN (w/English Abstract)	
		JP 11-39861A	02/12/1999	TOSHIBA CORP.		JAPAN (w/English Abstract)	
		JP 8-45271A	02/16/1996	SANYO ELECTRIC CO. LTD.		JAPAN (w/English Abstract)	
		JP 6-44773A	02/18/1994	NEC CORP.		JAPAN (w/English Abstract)	
		JP 5-101651A	04/23/1993	NEC CORP.		JAPAN (w/English Abstract)	
		JP 3-283180A	12/13/1991	NEC CORP.		JAPAN (w/English Abstract)	
		JP 62-223893A	10/1/1987	HITACHI LTD.		JAPAN (w/English Abstract)	
		P2001-184860A	07/06/2001	NEC IC MICROCOMPUT SYST LTD.		JAPAN (w/English Abstract)	
		WO96/28825	09/09/1996	HITACHI LTD.		JAPAN (w/English Abstract)	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
EXAMINER				DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.